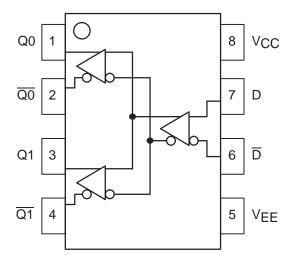
1:2 Differential Fanout Buffer

The MC10EP11 is a differential 1:2 fanout buffer. The device is pin and functionally equivalent to the LVEL11 device. With AC performance much faster than the LVEL11 device, the EP11 is ideal for applications requiring the fastest AC performance available.

- 220ps Typical Propagation Delay
- High Bandwidth to 3 GHz Typical
- PECL mode: 3.0V to 5.5V V_{CC} with $V_{EE} = 0V$
- ECL mode: 0V V_{CC} with $V_{EE} = -3.0V$ to -5.5V
- Internal Input Resistors: Pulldown on D, Pulldown and Pullup on \overline{D}
- Q Outputs will default LOW with inputs open or at V_{EE}
- ESD Protection: >4KV HBM, >200V MM
- New Differential Input Common Mode Range
- Moisture Sensitivity Level 1, Indefinite Time Out of Drypack. For Additional Information, See Application Note AND8003/D
- Flammability Rating: UL-94 code V-0 @ 1/8", Oxygen Index 28 to 34
- Transistor Count = 73 devices







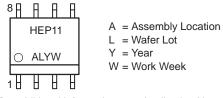
ON Semiconductor

Formerly a Division of Motorola http://onsemi.com



D SUFFIX CASE 751

MARKING DIAGRAM



*For additional information, see Application Note AND8002/D

PIN DESCRIPTION						
PIN	FUNCTION					
D, D	ECL Data Inputs					
Q0, <u>Q0</u> , Q1, <u>Q1</u>	ECL Data Outputs					

ORDERING INFORMATION

Device	Package	Shipping
MC10EP11D	SOIC	98 Units/Rail
MC10EP11DR2	SOIC	2500 Tape & Reel

MAXIMUM RATINGS*

Symbol	Parameter		Value	Unit			
V _{EE}	Power Supply ($V_{CC} = 0V$)	-6.0 to 0	VDC				
VCC	Power Supply (V _{EE} = 0V)	6.0 to 0	VDC				
VI	Input Voltage ($V_{CC} = 0V$, V_I not more negative the	Input Voltage (V_{CC} = 0V, V_{I} not more negative than V_{EE})					
VI	Input Voltage ($V_{EE} = 0V$, V_I not more positive that	6.0 to 0	VDC				
l _{out}	Output Current	Continuous Surge	50 100	mA			
т _А	Operating Temperature Range		-40 to +85	°C			
T _{stg}	Storage Temperature		-65 to +150	°C			
ΑL ^θ	Thermal Resistance (Junction-to-Ambient)	Still Air 500lfpm	190 130	°C/W			
θJC	Thermal Resistance (Junction-to-Case)		41 to 44 \pm 5%	°C/W			
T _{sol}	Solder Temperature (<2 to 3 Seconds: 245°C de	265	°C				

* Maximum Ratings are those values beyond which damage to the device may occur.

DC CHARACTERISTICS, ECL/LVECL ($V_{CC} = 0V$; $V_{EE} = -5.5V$ to -3.0V) (Note 4.)

			–40°C			25°C			85°C		
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
IEE	Power Supply Current (Note 1.)	20	29	37	20	30	39	22	31	40	mA
VOH	Output HIGH Voltage (Note 2.)	-1135	-1060	-885	-1070	-945	-820	-1010	-885	-760	mV
V _{OL}	Output LOW Voltage (Note 2.)	-1935	-1810	-1685	-1870	-1745	-1620	-1810	-1685	-1560	mV
VIH	Input HIGH Voltage Single Ended	-1210		-885	-1145		-820	-1085		-760	mV
VIL	Input LOW Voltage Single Ended	-1935		-1610	-1870		-1545	-1810		-1485	mV
VIHCMR	Input HIGH Voltage Common Mode Range (Note 3.)	VEE	+2.0	0.0	VEE	+2.0	0.0	VEE	+2.0	0.0	V
Iн	Input HIGH Current			150			150			150	μΑ
ΙL	Input LOW Current D D	0.5 -150			0.5 -150			0.5 -150			μA

NOTE: 10EP circuits are designed to meet the DC specifications shown in the above table after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse airflow greater than 500lfpm is maintained.
V_{CC} = 0V, V_{EE} = V_{EE}min to V_{EEmax}, all other pins floating.
All loading with 50 ohms to V_{CC}-2.0 volts.
V_{IHCMR} min varies 1:1 with V_{EE}, max varies 1:1 with V_{CC}.
Input and output parameters vary 1:1 with V_{CC}.

			–40°C		25°C			85°C			
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
IEE	Power Supply Current (Note 5.)	20	29	37	20	30	39	22	31	40	mA
VOH	Output HIGH Voltage (Note 6.)	2165	2240	2415	2230	2355	2480	2290	2415	2540	mV
VOL	Output LOW Voltage (Note 6.)	1365	1490	1615	1430	1555	1680	1490	1615	1740	mV
VIH	Input HIGH Voltage Single Ended	2090		2415	2155		2480	2215		2540	mV
VIL	Input LOW Voltage Single Ended	1365		1690	1430		1755	1490		1815	mV
VIHCMR	Input HIGH Voltage Common Mode Range (Note 7.)	2.0		3.3	2.0		3.3	2.0		3.3	V
Iн	Input HIGH Current	1		150			150			150	μA
۱L	Input LOW Current D D	0.5 -150			0.5 -150			0.5 150			μA

DC CHARACTERISTICS, LVPECL ($V_{CC} = 3.3V \pm 0.3V$, $V_{FF} = 0V$) (Note 8.)

NOTE: 10EP circuits are designed to meet the DC specifications shown in the above table after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse airflow greater than 500lfpm is maintained.

5. $V_{CC} = 3.3V$, $V_{EE} = 0V$, all other pins floating.

6. All loading with 50 ohms to V_{CC} -2.0 volts. 7. V_{IHCMR} min varies 1:1 with V_{EE} , max varies 1:1 with V_{CC} .

8. Input and output parameters vary 1:1 with V_{CC} .

DC CHARACTERISTICS, PECL ($V_{CC} = 5.0V \pm 0.5V$, $V_{FF} = 0V$) (Note 12.)

			–40°C			25°C			85°C		
Symbol	Characteristic	Min	Тур	Мах	Min	Тур	Max	Min	Тур	Max	Unit
IEE	Power Supply Current (Note 9.)	20	29	37	20	30	39	22	31	40	mA
VOH	Output HIGH Voltage (Note 10.)	3865	3940	4115	3930	4055	4180	3990	4115	4240	mV
VOL	Output LOW Voltage (Note 10.)	3065	3190	3315	3130	3255	3380	3190	3315	3440	mV
VIH	Input HIGH Voltage Single Ended	3790		4115	3855		4180	3915		4240	mV
VIL	Input LOW Voltage Single Ended	3065		3390	3130		3455	3190		3515	mV
VIHCMR	Input HIGH Voltage Common Mode Range (Note 11.)	2.0		5.0	2.0		5.0	2.0		5.0	V
IIН	Input HIGH Current			150			150			150	μΑ
ΙL	Input LOW Current D D	0.5 -150			0.5 -150			0.5 -150			μA

NOTE: 10EP circuits are designed to meet the DC specifications shown in the above table after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse airflow greater than 500lfpm is maintained.

9. $V_{CC} = 5.0V$, $V_{EE} = 0V$, all other pins floating.

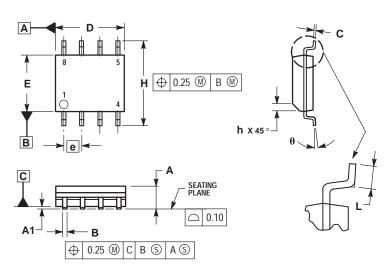
10. All loading with 50 ohms to V_{CC} -2.0 volts. 11. V_{IHCMR} min varies 1:1 with V_{EE} , max varies 1:1 with V_{CC} . 12. Input and output parameters vary 1:1 with V_{CC} .

			–40°C			25°C			85°C		
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
f _{max}	Maximum Toggle Frequency (Note 13.)		3.0			3.0			3.0		GHz
tPLH, tPHL	Propagation Delay (Diff.) CLK->Q, Q	140	200	270	160	220	300	180	240	320	ps
^t SKEW	Device Skew Q, \overline{Q} Part–to–Part (Note 14.)		TBD TBD			TBD TBD			TBD TBD		ps
^t JITTER	Cycle-to-Cycle Jitter		TBD			TBD			TBD		ps
VPP	Input Voltage Swing (Diff.)	150	800	1200	150	800	1200	150	800	1200	mV
t _r t _f	Output Rise/Fall Times $(20\% - 80\%)$ Q, \overline{Q}	50	110	180	60	120	200	70	140	220	ps

13. F_{max} guaranteed for functionality only. V_{OL} and V_{OH} levels are guaranteed at DC only. 14. Skew is measured between outputs under identical transitions.

PACKAGE DIMENSIONS

SO-8 **D SUFFIX** PLASTIC SOIC PACKAGE CASE 751-06 ISSUE T



- NOTES:
 DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 DIMENSIONS ARE IN MILLIMETER.
 DIMENSION D AND E DO NOT INCLUDE MOLD PROTRUSION.
 MAXIMUM MOLD PROTRUSION 0.15 PER SIDE.
 DIMENSION B DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 TOTAL IN EXCESS OF THE B DIMENSION AT MAXIMUM MATERIAL CONDITION.

	MILLIMETERS									
DIM	MIN	MAX								
Α	1.35	1.75								
A1	0.10	0.25								
В	0.35	0.49								
С	0.19	0.25								
D	4.80	5.00								
E	3.80	4.00								
e	1.27	BSC								
Н	5.80	6.20								
h	0.25	0.50								
L	0.40	1.25								
θ	0 °	7 °								

<u>Notes</u>

<u>Notes</u>

ON Semiconductor and without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer.

PUBLICATION ORDERING INFORMATION

USA/EUROPE Literature Fulfillment:

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA Phone: 303–675–2175 or 800–344–3860 Toll Free USA/Canada Fax: 303–675–2176 or 800–344–3867 Toll Free USA/Canada Email: ONlit@hibbertco.com

Fax Response Line*: 303–675–2167 800–344–3810 Toll Free USA/Canada *To receive a Fax of our publications

N. America Technical Support: 800-282-9855 Toll Free USA/Canada

ASIA/PACIFIC: LDC for ON Semiconductor – Asia Support Phone: 303–675–2121 (Tue–Fri 9:00am to 1:00pm, Hong Kong Time) Email: ONlit–asia@hibbertco.com

JAPAN: ON Semiconductor, Japan Customer Focus Center 4–32–1 Nishi–Gotanda, Shinagawa–ku, Tokyo, Japan 141–8549 Phone: 81–3–5487–8345 Email: r14153@onsemi.com

ON Semiconductor Website: http://onsemi.com

For additional information, please contact your local Sales Representative.